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				Application Number	Not yet assigned
				Confirmation Number	<del>Not yet assigned</del>
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				First Named Inventor	Katsuhiro TAKENAGA
				Art Unit	<del>Not yet assigned</del>
Examiner Name	<del>Not yet assigned</del> T. Pajoochi				
Attorney Docket Number	Q96164				
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number	Kind Code <sup>2</sup> (if known)		
		US 2003/128942	A	07-10-2003	DiGiovanni et al.
		US 2003/0128942			
		US			
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		US			
		US			

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Translation <sup>6</sup>
		Country Code <sup>3</sup>	Number <sup>4</sup>	Kind Code <sup>5</sup> (if known)			
		JP	60-214235	A	10-26-1985	Hitachi Cable, Ltd.	
		JP	5-248996	A	09-28-1993	Nippon Telegraph and Telephone Corp.	
		JP	2003-195085	A	07-09-2003	Fitel USA Corp	

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation <sup>6</sup>
		IEC PAS 60793-1-49: "Optical fibres - Part 1-49: Measurement methods and test procedures 0 Differential Mode Delay", May, 2005.	
		Shin-Etsu Quartz Products Co., Ltd., Quartz Glass Technical Guide - 2 Optical Properties of Quartz Glass, p. 7. ( <a href="http://www.sqp.co.jp/seihin/catalog/pdf/g2.pdf">http://www.sqp.co.jp/seihin/catalog/pdf/g2.pdf</a> )	
		Shin-Etsu Quartz Products Co., Ltd., Quartz Glass Technical Guide - 1 Chemical and Physical Properties of Quartz Glass, p. 7. <a href="http://www.sqp.co.jp/seihin/catalog/pdf/g1.pdf">http://www.sqp.co.jp/seihin/catalog/pdf/g1.pdf</a>	

Examiner Signature	/Tara Pajoochi/	Date Considered	12/30/2009
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ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /T.P./

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